

Notice of References Cited	Application/Control No. 10/064,477	Applicant(s)/Patent Under Reexamination FANO, ANDREW E.	
	Examiner Cindy Nguyen	Art Unit 2171	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0166123	11-2002	Schrader et al.	725/58
*	B	US-6,023,705	02-2000	Bellinger et al.	707/200
*	C	US-6,144,375	11-2000	Jain et al.	715/500.1
*	D	US-2003/0009469	01-2003	Platt et al.	707/100
*	E	US-5,822,537	10-1998	Katseff et al.	709/231
*	F	US-2001/0031066	10-2001	Meyer et al.	382/100
*	G	US-2,002,00072	05-1935	COLBURN JR ERNEST A	366/164.6
	H	US-6,151,632	11-2000	Chaddha et al.	709/231
	I	US-2002/0083060	06-2002	Wang et al.	707/10
*	J	US-2003/0120793	06-2003	Marjola, Pekka	709/231
*	K	US-2003/0018647	01-2003	Bialkowski, Jan	707/101
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.